

<b>Notice of References Cited</b>	Application/Control No. 10/501,522	Applicant(s)/Patent Under Reexamination ADACHI ET AL.	
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#### U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,060,344	05-2000	Matsui et al.	438/164
	B	US-6,124,185	09-2000	Doyle, Brian S.	438/458
	C	US-6,114,197	09-2000	Hsu, Sheng Teng	438/199
	D	US-2002/0190319	12-2002	Borenstein, Jeffrey	257/347
	E	US-6,809,009	10-2004	Aspar et al.	438/459
	F	US-6,673,694	01-2004	Borenstein, Jeffrey T.	438/411
	G	US-5,804,086	09-1998	Bruel, Michel	216/33
	H	US-6,759,282	07-2004	Campbell et al.	438/149
	I	US-6,534,380	03-2003	Yamauchi et al.	438/455
	J	US-2004/0070032	04-2004	Mori et al.	257/348
	K	US-			
	L	US-			
	M	US-			

#### FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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	V	
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	X	

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